



• General Description

It combines trench MOSFET technology with a low resistance package to provide extremely low $R_{DS(ON)}$. It is suitable for automotive application.

• Features

- AEC-Q101 Qualified
- Low $R_{DS(ON)}$ to minimize conductive loss
- Low Gate Charge for fast switching
- Low Thermal resistance

• Application

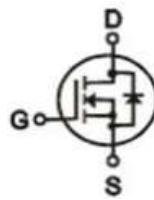
- BLDC Motor driver
- DC-DC
- Load Switch

• Ordering Information:

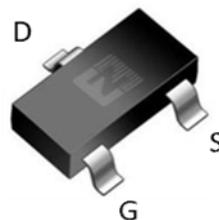
Part NO.	ZMA012KN06T
Marking	012KN06
Packing Information	TAPE REEL
Basic ordering unit (pcs)	3000

• Absolute Maximum Ratings ($T_C=25^\circ\text{C}$)

Parameter	Symbol	Conditions	Value	Unit
Drain-Source Voltage	V_{DS}		60	V
Gate-Source Voltage	V_{GS}		± 12	V
Continuous Drain Current	I_D	$T_C=25^\circ\text{C}$	1.4	A
	I_D	$T_C=75^\circ\text{C}$	1.2	A
	I_D	$T_C=100^\circ\text{C}$	1.0	A
Pulsed Drain Current ^①	I_{DM}	Pulsed; $t_p \leq 10 \mu\text{s}$; $T_{mb} = 25^\circ\text{C}$	5.6	A
Total Power Dissipation	P_D	$T_C=25^\circ\text{C}$	1.4	W
Total Power Dissipation	P_D	$T_A=25^\circ\text{C}$	0.7	W
Operating Junction Temperature	T_J		-55 to +150	$^\circ\text{C}$
Storage Temperature	T_{STG}		-55 to +150	$^\circ\text{C}$
Single Pulse Avalanche Energy	E_{AS}	$L=0.1\text{mH}$, $VGS=10\text{V}$, $Rg=25\Omega$,	3.2	mJ
		$L=0.5\text{mH}$, $VGS=10\text{V}$, $Rg=25\Omega$,	5.8	mJ
ESD Level (HBM)			CLASS 2	



$V_{DS}= 60\text{V}$
 $R_{DS(ON)} = 165\text{m}\Omega$
 $I_D = 1.4\text{A}$



SOT-23-3





•Thermal resistance

Parameter	Symbol	Min.	Typ.	Max.	Unit
Thermal resistance, junction - case	R _{thJC}		-	90	°C/W
Thermal resistance, junction-ambient	R _{thJA}		-	180	°C/W
Soldering temperature (total time<10s)	T _{sold}		-	260	°C

•Electronic Characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Drain-Source Breakdown Voltage	BV _{DSS}	V _{GS} =0V, I _D =250μA	60			V
Gate Threshold Voltage	V _{GS(TH)}	V _{GS} =V _{DS} , I _D =250μA	0.5	1	1.5	V
Drain-Source Leakage Current	I _{DSS}	V _{GS} =0V, V _{DS} = 60V			1.0	uA
Gate- Source Leakage Current	I _{GSS}	V _{GS} =±12V, V _{DS} = 0V			100	nA
Static Drain-source On Resistance	R _{DS(ON)}	V _{GS} =4.5V, I _D = 2A		165	215	mΩ
		V _{GS} =2.5V, I _D = 1A		175	230	mΩ
Forward Transconductance	g _{FS}	V _{GS} =5V, I _{SD} = 1A		3		S
Diode Forward Voltage	V _{FSD}	V _{GS} =0V, I _{SD} = 2A			1.3	V

•Dynamic characteristics

Parameter	Symbol	Condition	Min.	Typ.	Max.	Unit
Input capacitance	C _{iss}	f = 1MHz, V _{DS} =25V	-	587	-	pF
Output capacitance	C _{oss}		-	15	-	
Reverse transfer capacitance	C _{rss}		-	11	-	
Gate Resistance	R _g	f = 1MHz	-	2.4		Ω
Total gate charge	Q _g	V _{DD} = 15V, I _D = 2A, V _{GS} = 10V	-	12.8	-	nC
Total gate charge	Q _g (4.5V)		-	5.6	-	
Gate - Source charge	Q _{gs}		-	1	-	
Gate - Drain charge	Q _{gd}		-	1.4	-	
Turn-ON Delay time	t _{D(on)}	V _{GS} =10V, V _{DS} =15V, R _G =3.3Ω, I _D =2A	-	6	-	ns
Turn-ON Rise time	t _r		-	8	-	ns
Turn-Off Delay time	t _{D(off)}		-	14	-	ns
Turn-Off Fall time	t _f		-	3	-	ns
Reverse Recovery Time	t _{rr}	V _{DD} =20V, dI _S /dt = 100A/us, I _S =2A	-	13	-	ns
Reverse Recovery Charge	Q _{rr}		-	6	-	nC

Fig.1 Gate-Charge Characteristics

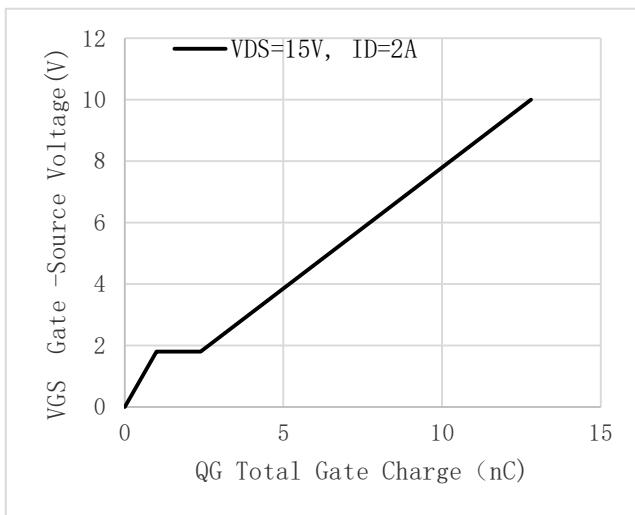


Fig.2 Capacitance Characteristics

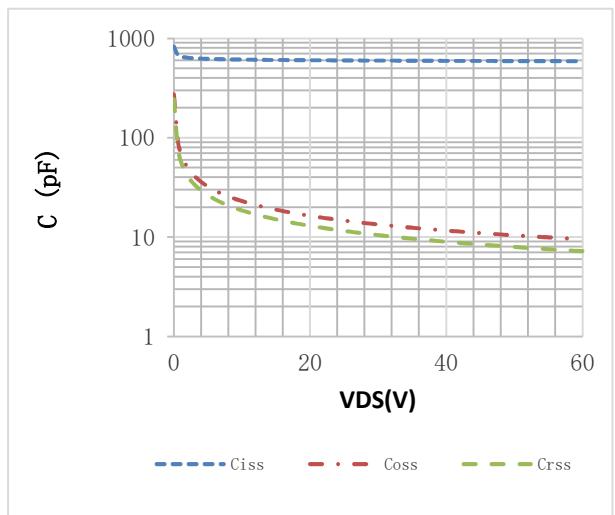


Fig.3 Power Dissipation

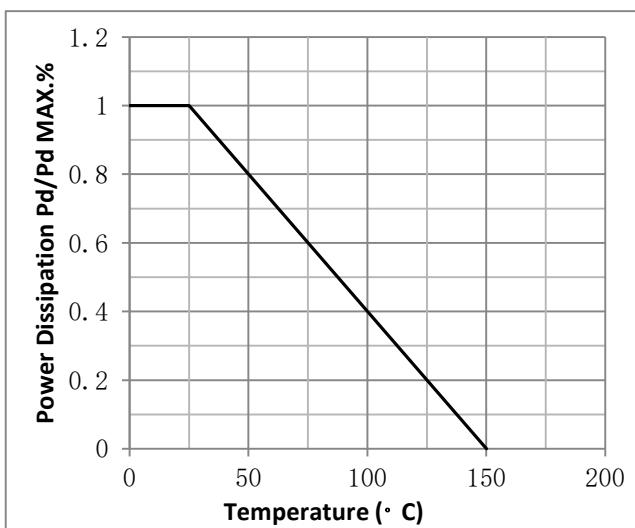


Fig.4 Typical output Characteristics

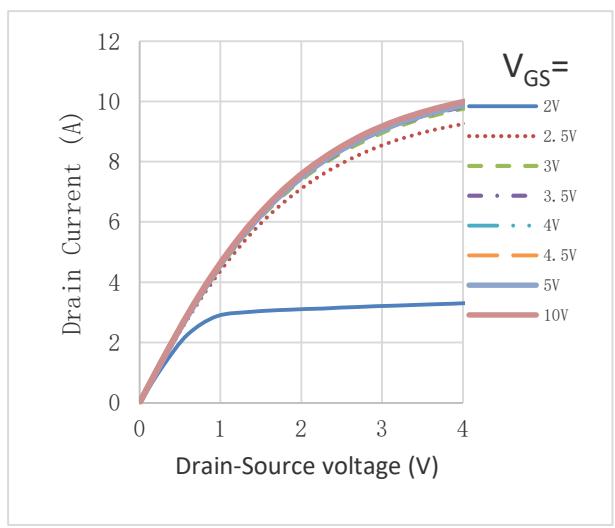


Fig.5 Threshold Voltage V.S Junction Temperature

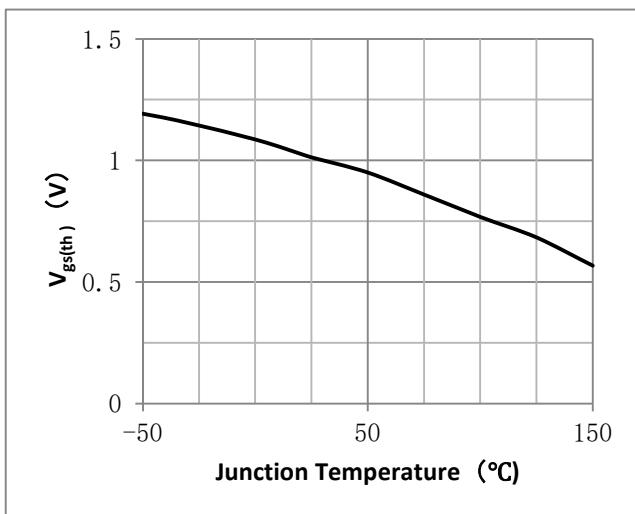


Fig.6 Resistance V.S Drain Current

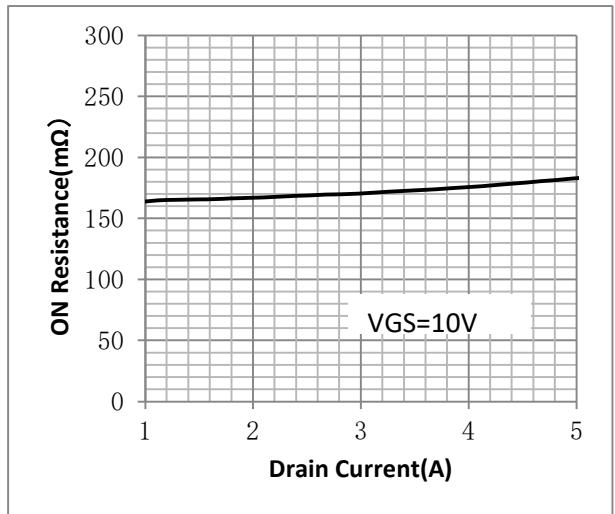


Fig.7 On-Resistance VS Gate Source Voltage

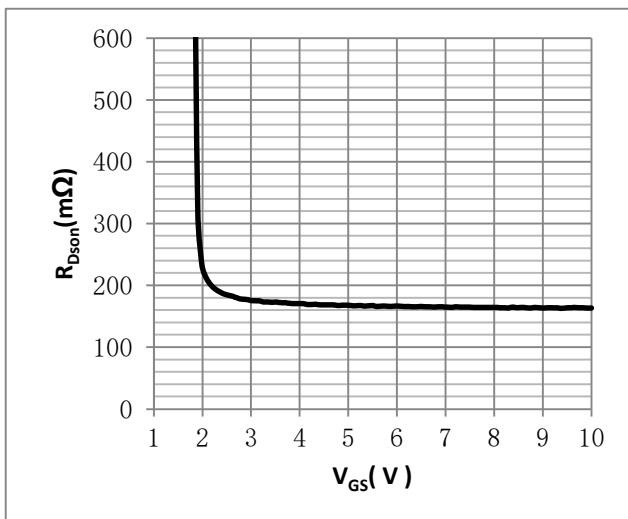


Fig.8 On-Resistance V.S Junction Temperature

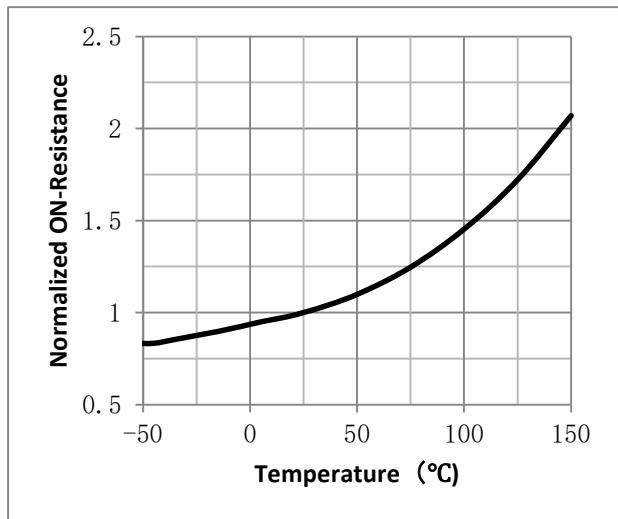


Figure 9. Diode Forward Voltage vs. Current

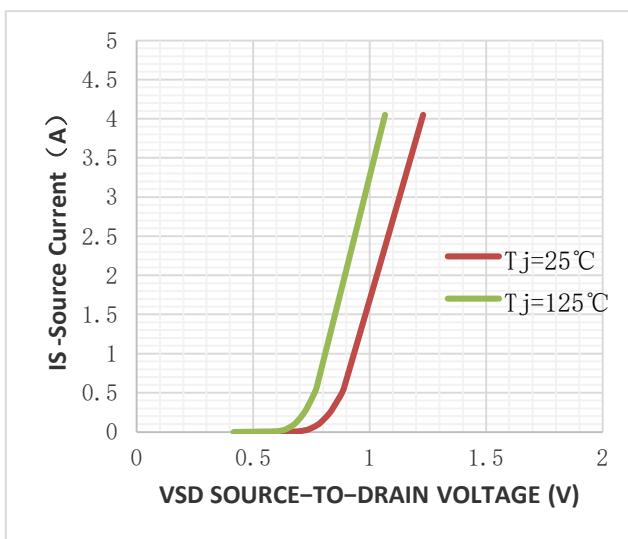


Figure 10. Transfer Characteristics

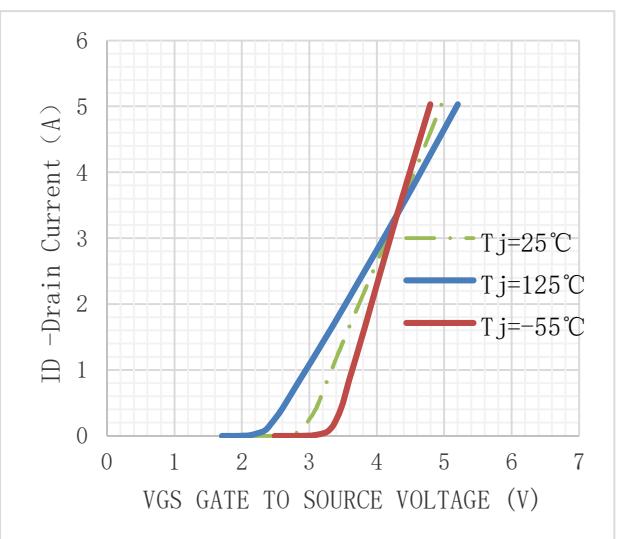


Fig.11 SOA Maximum Safe Operating Area

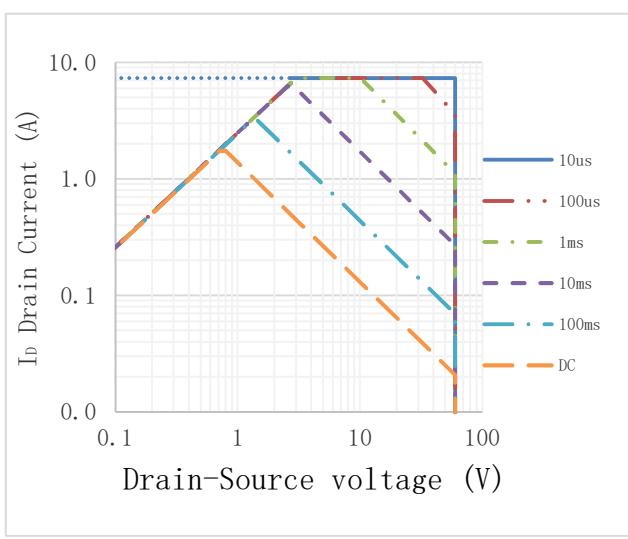
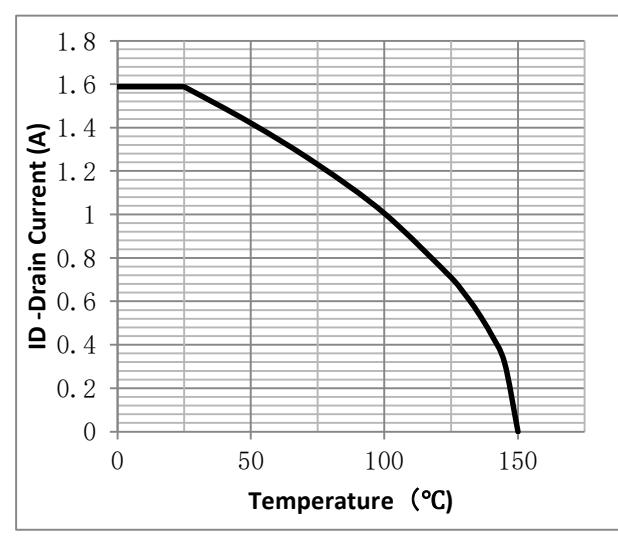
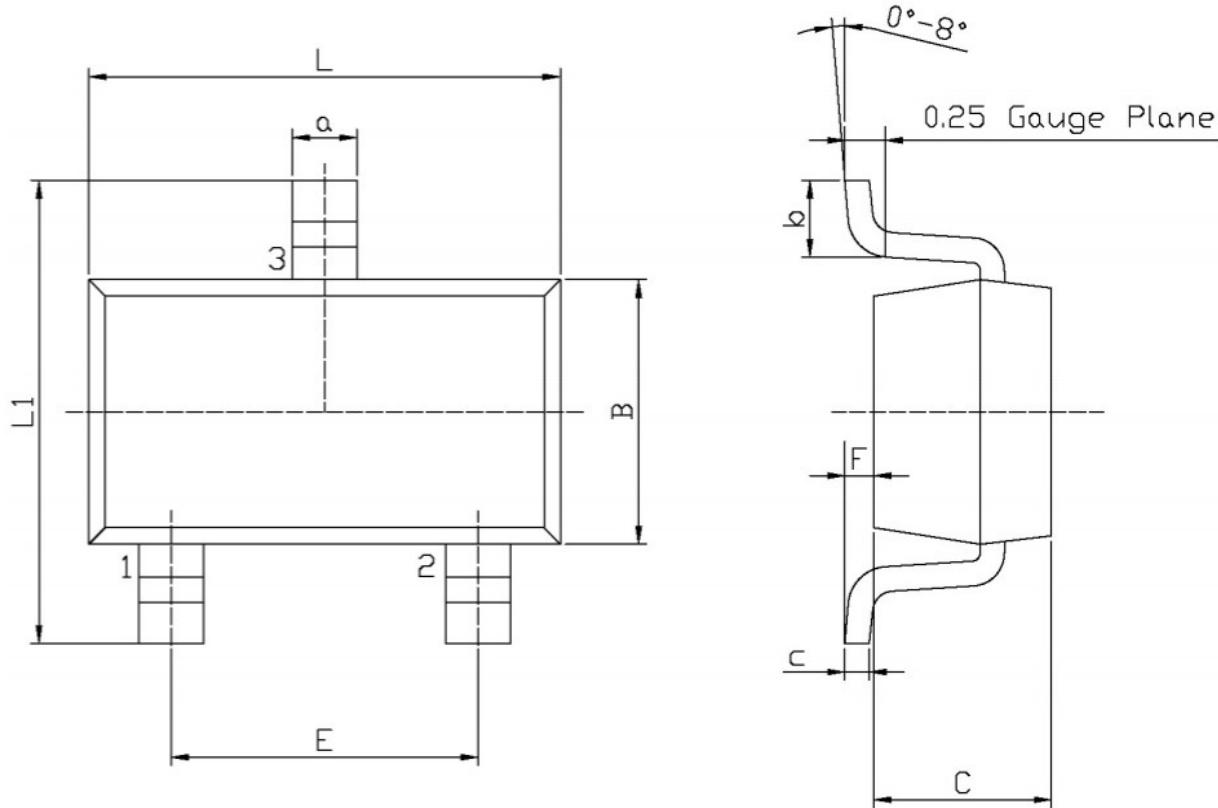


Fig.12 ID vs. Junction Temperature②





•SOT-23-3 Package Outline



Unit: mm

Symbol	Dimensions In Millimeters		Symbol	Dimensions In Millimeters	
	Min	Max		Min	Max
L	2.82	3.02	a	0.35	0.50
B	1.50	1.70	c	0.10	0.20
C	0.90	1.30	b	0.35	0.55
L1	2.60	3.00	F	0	0.15
E	1.80	2.00			

**Note:**

① Device mounted on FR-4 substrate PC board, 2oz copper, with thermal bias to bottom layer 1inch square copper plate;

② Practically the current will be limited by PCB, thermal design and operating temperature. $V_{GS}=10V$.

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Revision History

Version	Date	Change
A	2024/8/16	New